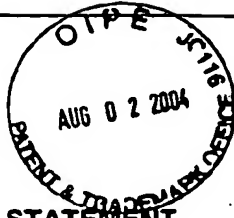


FORM PTO-1449 (modified)  
To: U.S. Department of Commerce  
(PW FORM PAT-1449)  
Patent and Trademark Office



Atty. Dkt. No.	C#/M#	Client Ref.
	008312-0290735	T4YK-01S0958-1

**INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT**

Applicant: Shuichi HISATOMI, et al.	
Appln. No.: 10/082,355	
Filing Date: February 26, 2002	
Examiner: UNKNOWN	Group Art Unit: 2643

Date: August 2, 2004

Page 1 of 1

**U.S. PATENT DOCUMENTS**

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
GW	OR	2001-86444	03/2001	Japan	ASADA et al.	X			X
	PR								
	QR								
	RR								
	SR								
	TR								
	UR								
	VR								
	WR								
	XR								

**OTHER (including in this order: Author, Title, Periodical Name, Date, Pertinent Pages, etc.)**

GW	YR	Japanese Office Action, dated June 22, 2004 for Patent Application No. 2001-050456					X	X	
	ZR								
	AAR								
	BBR								
	CCR								

Examiner /Girumsew Wendmagegn/ Date Considered: 08/18/2006

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

#5 S.W.H. 8/30/02

FORM PTO-1449 (modified) To: U.S. Department of Commerce (P.W. FORM PAT-1449) Patent and Trademark Office				Atty. Dkt. No. M		Client Ref.				
				290735		T4YK-01S0958-1				
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				Applicant: HISATOMI et al.						
				Appln. No.:						
				Filing Date:						
				Examiner:		Group Art Unit:				
Date: February 26, 2002      Page 1 of 1				1971 U.S. PTO 10/0235 02/26/02						
<b>U.S. PATENT DOCUMENTS</b>										
Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)			Class	Sub Class	Filing Date (if appropriate)		
	AR									
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<b>FOREIGN PATENT DOCUMENTS</b>								English Abstract	Translation Readily Available	
		Document Number	Date MM/YYYY	Country	Inventor Name		Enclosed	No	Enclose	No
GW	OR	2001-86466	03/2001	JAPAN			x			x
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Examiner /Girumsew Wendmagegn/						Date Considered: 09/28/2006				
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